Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination TANAKA, KOICHIRO	
10/721,075		
Examiner	Art Unit	
M. Alexandra Elve	1725	

SEARCHED					
Class	Subclass	Date	Examiner		
219	121.76	6/3/2005	MAE		
219	121.78	6/3/2005	MAE		
219	121.81	6/3/2005	MAE		
219	121.85	6/3/2005	MAE		
219	121.65	6/3/2005	MAE		
219	121.66	6/3/2005	MAE		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
219	121.76	6/23/2005	MAE		
219	121.78	6/23/2005	MAE		
219	121.85	6/23/2005	MAE		

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
US OCR, US PAT, US PG, Derwent, JPO, EPO (see attached search strategy)	6/3/2005	MAE
Inventor search (PALM)	6/3/2005	MAE